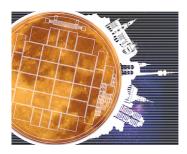
13th "Trento" Workshop on Advanced Silicon Radiation Detectors



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E-TCT characterisation of irradiated backside biased H35DEMO pixel demonstrators

Tuesday 20 February 2018 12:30 (15 minutes)

Presenter: Mr FRANKS, Matthew (University of Liverpool)

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